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SAR Evaluation Report

Application No.:	SZEM1611009573CR
Applicant:	Plantronics, Inc.
Manufacturer:	Plantronics, Inc.
Product Name:	Stereo Bluetooth headset
Model No.(EUT):	S5XX17
Trade Mark:	Plantronics
FCC ID:	AL8-S5XX17
Standards:	47 CFR Part 1.1307 (2015) 47 CFR Part 2.1093 (2015)
	KDB447498D01 General RF Exposure Guidance v06
Date of Receipt:	2016-11-14
Date of Test:	2016-11-22 to 2016-11-29
Date of Issue:	2016-11-30
Test Result :	PASS*

* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



Jack Zhang EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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2 Version

Revision Record				
Version	Chapter	Date	Modifier	Remark
00		2016-11-30		Original

Tested By	Zdison Li (Edison Li) /Project Engineer	2016-11-29
Checked By	Eric Fu (Eric Fu) /Reviewer	2016-11-30

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4 General Information

4.1 Client Information

Applicant:	Plantronics, Inc.
Address of Applicant:	345 Encinal St., Santa Cruz, CA 95060, USA
Manufacturer:	Plantronics, Inc.
Address of Manufacturer:	345 Encinal St., Santa Cruz, CA 95060, USA

4.2 General Description of EUT

Product Name:	Stereo Bluetooth headset
Model No.:	S5XX17
Trade Mark:	Plantronics
Frequency Range:	2402MHz to 2480MHz
Bluetooth Version:	V4.1 Classic mode
Modulation Technique:	Frequency Hopping Spread Spectrum(FHSS)
Modulation Type:	GFSK, π/4DQPSK, 8DPSK
Number of Channels:	79
Hopping Channel Type:	Adaptive Frequency Hopping systems
Sample Type:	Portable production
Antenna Type:	Integral
Antenna Gain:	3.11dBi
Power Supply:	Internal rechargeable battery: DC 3.7V 360mAh Battery: Charge by USB DC 5V
Cable:	USB cable: 30cm unshielded Audio in cable: 150cm unshielded



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4.3 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China 518057

Telephone: +86 (0) 755 2601 2053 Fax: +86 (0) 755 2671 0594 No tests were sub-contracted.

4.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

• VCCI

The 10m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

FCC – Registration No.: 556682

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.: 556682.

Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

4.5 Deviation from Standards

None.

4.6 Abnormalities from Standard Conditions

None.

4.7 Other Information Requested by the Customer

None.



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5 SAR Evaluation

5.1 RF Exposure Compliance Requirement

5.1.1 Standard Requirement

According to KDB447498D01 General RF Exposure Guidance v06

4.3.1. Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Exclusion Threshold condition, listed below, is satisfied.

5.1.2 Limits

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances \leq 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] \cdot [$\sqrt{f}(GHz)$] \leq 3.0 for 1-g SAR and \leq 7.5 for 10-g extremity SAR, where

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation¹⁷ The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is \leq 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation

distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion

5.1.3 EUT RF Exposure

The Max Conducted Peak Output Power is 8.27dBm in middle channel(2.441GHz);

8.27dBm logarithmic terms convert to numeric result is nearly 6.71mW

According to the formula. calculate the test exclusion thresholds:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] \cdot [$\sqrt{f}(GHz)$]

General RF Exposure = (6.71mW / 18 mm) x $\sqrt{2.441}$ GHz = 0.58 (1)

SAR requirement:

S= 3.0

2;

< 2.
So the SAR report is not required.

Remark:

The minimum separation distance between the user and/or bystander and the antenna and/or radiating element of the device is equal to 18 mm.